

DS90CR583/DS90CR584 LVDS 24-Bit Color Flat Panel Display (FPD) Link— 65 MHz

Check for Samples: [DS90CR583](#), [DS90CR584](#)

FEATURES

- 20 to 65 MHz Shift clk Support
- Up to 227 Mbytes/s Bandwidth
- Cable Size is Reduced to Save Cost
- 290 mV Swing LVDS Devices for Low EMI
- Low Power CMOS Design (< 550 mW typ)
- Power-Down Mode Saves Power (< 0.25 mW)
- PLL Requires No External Components
- Low Profile 56-lead TSSOP Package
- Rising Edge Data Strobe
- Compatible with TIA/EIA-644 LVDS Standard
- Single Pixel Per Clock XGA (1024 x 768)
- Supports VGA, SVGA, XGA and Higher
- 1.8 Gbps Throughput

DESCRIPTION

The DS90CR583 transmitter converts 28 bits of CMOS/TTL data into four LVDS (Low Voltage Differential Signaling) data streams. A phase-locked transmit clock is transmitted in parallel with the data streams over a fifth LVDS link. Every cycle of the transmit clock 28 bits of input data are sampled and transmitted. The DS90CR584 receiver converts the LVDS data streams back into 28 bits of CMOS/TTL data. At a transmit clock frequency of 65 MHz, 24 bits of RGB data and 4 bits of LCD timing and control data (FPLINE, FPFRAME, DRDY, CNTL) are transmitted at a rate of 455 Mbps per LVDS data channel. Using a 65 MHz clock, the data throughput is 227 Mbytes per second. These devices are offered with rising edge data strobes for convenient interface with a variety of graphics and LCD panel controllers.

This chipset is an ideal means to solve EMI and cable size problems associated with wide, high speed TTL interfaces.

BLOCK DIAGRAM

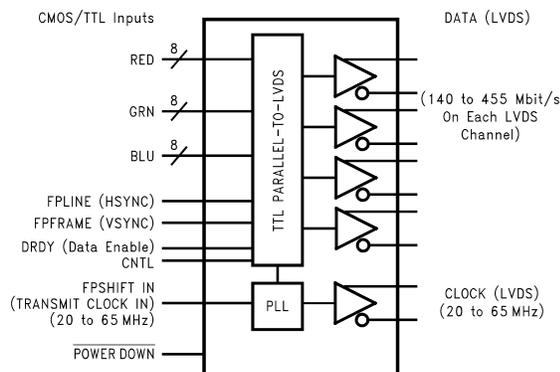


Figure 1. DS90CR583
See Package Number DGG

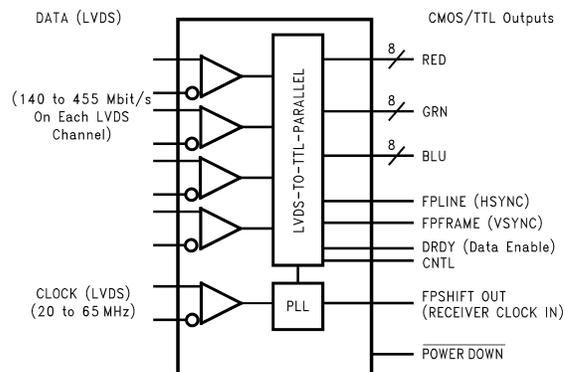
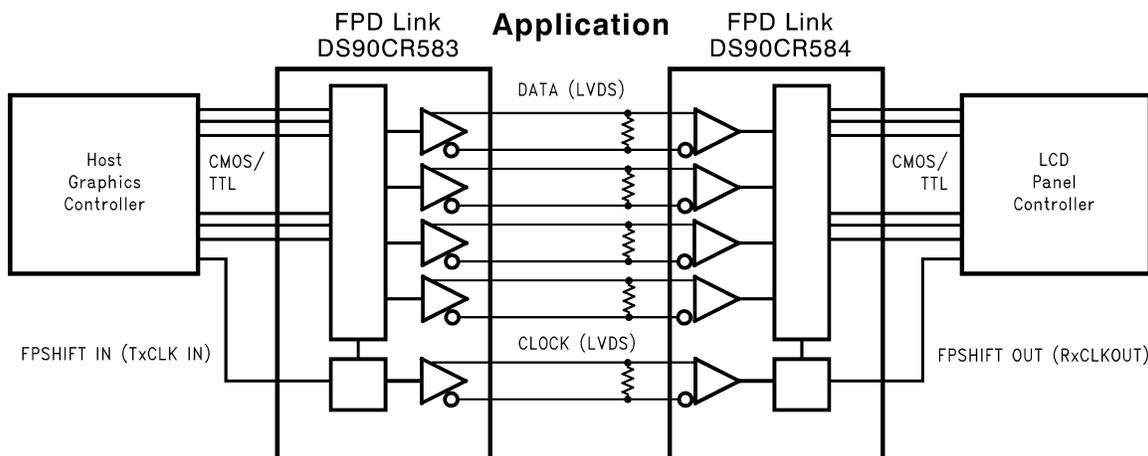


Figure 2. DS90CR584
See Package Number DGG



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Absolute Maximum Ratings⁽¹⁾⁽²⁾

| | | | | |
|---|----------------------|-----------|------------------------|------------------------------|
| Supply Voltage (V_{CC}) | | | | -0.3V to +6V |
| CMOS/TTL Input Voltage | | | | -0.3V to ($V_{CC} + 0.3V$) |
| CMOS/TTL Output Voltage | | | | -0.3V to ($V_{CC} + 0.3V$) |
| LVDS Receiver Input Voltage | | | | -0.3V to ($V_{CC} + 0.3V$) |
| LVDS Driver Output Voltage | | | | -0.3V to ($V_{CC} + 0.3V$) |
| LVDS Output Short Circuit Duration | | | | Continuous |
| Junction Temperature | | | | +150°C |
| Storage Temperature | | | | -65°C to +150°C |
| Lead Temperature (Soldering, 4 sec) | | | | +260°C |
| Maximum Power Dissipation @ 25°C | DGG (TSSOP) Package: | DS90CR583 | 1.63W | |
| | | DS90CR584 | 1.61W | |
| | Package Derating: | DS90CR583 | 12.5 mW/°C above +25°C | |
| | | DS90CR584 | 12.4 mW/°C above +25°C | |
| This device does not meet 2000V ESD rating ⁽³⁾ . | | | | |

- (1) "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be ensured. They are not meant to imply that the device should be operated at these limits. "Electrical Characteristics" specify conditions for device operation.
 (2) If Military/Aerospace specified devices are required, please contact the TI Sales Office/ Distributors for availability and specifications.
 (3) ESD Rating: HBM (1.5 k Ω , 100 pF) PLL $V_{CC} \geq 1000V$ All other pins $\geq 2000V$ EIAJ (0 Ω , 200 pF) $\geq 150V$

Recommended Operating Conditions

| | Min | Nom | Max | Units |
|--|------|-----|------|-------------------|
| Supply Voltage (V_{CC}) | 4.75 | 5.0 | 5.25 | V |
| Operating Free Air Temperature (T_A) | -10 | +25 | +70 | °C |
| Receiver Input Range | 0 | | 2.4 | V |
| Supply Noise Voltage (V_{CC}) | | | 100 | mV _{P-P} |

ELECTRICAL CHARACTERISTICS

over recommended operating supply and temperature ranges unless otherwise specified
 operating free-air temperature range (unless otherwise noted)

| Symb | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------------|--------------------------|------------|-----|-----|----------|-------|
| CMOS/TTL DC SPECIFICATIONS | | | | | | |
| V_{IH} | High Level Input Voltage | | 2.0 | | V_{CC} | V |

ELECTRICAL CHARACTERISTICS (continued)

over recommended operating supply and temperature ranges unless otherwise specified
 rating free-air temperature range (unless otherwise noted)

| Symb | Parameter | Conditions | Min | Typ | Max | Units | |
|--|---|---|------------------------|-------|------|-------|----|
| V _{IL} | Low Level Input Voltage | | GND | | 0.8 | V | |
| V _{OH} | High Level Output Voltage | I _{OH} = -0.4 mA | 3.8 | 4.9 | | V | |
| V _{OL} | Low Level Output Voltage | I _{OL} = 2 mA | | 0.1 | 0.3 | V | |
| V _{CL} | Input Clamp Voltage | I _{CL} = -18 mA | | -0.79 | -1.5 | V | |
| I _{IN} | Input Current | V _{IN} = V _{CC} , GND, 2.5V or 0.4V | | ±5.1 | ±10 | µA | |
| I _{OS} | Output Short Circuit Current | V _{OUT} = 0V | | | -120 | mA | |
| LVDS DRIVER DC SPECIFICATIONS | | | | | | | |
| V _{OD} | Differential Output Voltage | R _L = 100Ω | 250 | 290 | 450 | mV | |
| ΔV _{OD} | Change in V _{OD} between Complementary Output States | | | | 35 | mV | |
| ΔV _{CM} | Change in V _{CM} between Complementary Output States | | | | 35 | mV | |
| V _{OL} | Low Level Output Voltage | | 0.9 | 1.01 | | V | |
| I _{OS} | Output Short Circuit Current | V _{OUT} = 0V, R _L = 100Ω | | -2.9 | -5 | mA | |
| I _{OZ} | Output TRI-STATE Current | Power Down = 0V, V _{OUT} = 0V or V _{CC} | | ±1 | ±10 | µA | |
| LVDS RECEIVER DC SPECIFICATIONS | | | | | | | |
| V _{TH} | Differential Input High Threshold | V _{CM} = +1.2V | | | +100 | mV | |
| V _{TL} | Differential Input Low Threshold | | -100 | | | mV | |
| I _{IN} | Input Current | V _{IN} = +2.4V | V _{CC} = 5.5V | | ±10 | µA | |
| | | V _{IN} = 0V | | | ±10 | µA | |
| TRANSMITTER SUPPLY CURRENT | | | | | | | |
| I _{CCTW} | Transmitter Supply Current, Worst Case | R _L = 100Ω, C _L = 5 pF, Worst Case Pattern (Figure 3, Figure 5) | f = 32.5 MHz | | 49 | 63 | mA |
| | | | f = 37.5 MHz | | 51 | 64 | mA |
| | | | f = 65 MHz | | 70 | 84 | mA |
| I _{CCTG} | Transmitter Supply Current, 16 Grayscale | R _L = 100Ω, C _L = 5 pF, 16 Grayscale Pattern (Figure 4, Figure 5) | f = 32.5 MHz | | 40 | 55 | mA |
| | | | f = 37.5 MHz | | 41 | 55 | mA |
| | | | f = 65 MHz | | 55 | 67 | mA |
| I _{CCTZ} | Transmitter Supply Current, Power Down | Power Down = Low | | | 1 | 10 | µA |
| I _{CCRW} | Receiver Supply Current, Worst Case | C _L = 8 pF, Worst Case Pattern (Figure 3, Figure 6) | f = 32.5 MHz | | 64 | 77 | mA |
| | | | f = 37.5 MHz | | 70 | 85 | mA |
| | | | f = 65 MHz | | 110 | 140 | mA |
| I _{CCRG} | Receiver Supply Current, 16 Grayscale | C _L = 8 pF, 16 Grayscale Pattern (Figure 4, Figure 6) | f = 32.5 MHz | | 35 | 55 | mA |
| | | | f = 37.5 MHz | | 37 | 55 | mA |
| | | | f = 65 MHz | | 55 | 67 | mA |
| I _{CCRZ} | Receiver Supply Current, Power Down | Power Down = Low | | | 1 | 10 | µA |

Transmitter Switching Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified

| Symbol | Parameter | Min | Typ | Max | Units |
|--------|--|-----|------|-----|-------|
| LLHT | LVDS Low-to-High Transition Time (Figure 5) | | 0.75 | 1.5 | ns |
| LHLT | LVDS High-to-Low Transition Time (Figure 5) | | 0.75 | 1.5 | ns |
| TCIT | TxCLK IN Transition Time (Figure 7) | | | 8 | ns |
| TCCS | TxOUT Channel-to-Channel Skew ⁽¹⁾ (Figure 8) | | | 350 | ps |
| TCCD | TxCLK IN to TxCLK OUT Delay @ 25°C, V _{CC} = 5.0V (Figure 11) | 3.5 | | 8.5 | ns |

(1) This limit based on bench characterization.

Transmitter Switching Characteristics (continued)

Over recommended operating supply and temperature ranges unless otherwise specified

| Symbol | Parameter | Min | Typ | Max | Units | |
|--------|---|------------|-------|----------------------|-------|----|
| TCIP | TxCLK IN Period (Figure 9) | 15 | T | 50 | ns | |
| TCIH | TxCLK IN High Time (Figure 9) | 0.35T | 0.5T | 0.65T | ns | |
| TCIL | TxCLK IN Low Time (Figure 9) | 0.35T | 0.5T | 0.65T | ns | |
| TSTC | TxIN Setup to TxCLK IN (Figure 9) | f = 65 MHz | 5 | 3.5 | ns | |
| THTC | TxIN Hold to TxCLK IN (Figure 9) | | 2.5 | 1.5 | ns | |
| TPDD | Transmitter Powerdown Delay (Figure 20) | | | | 100 | ns |
| TPLLS | Transmitter Phase Lock Loop Set (Figure 13) | | | | 10 | ms |
| TPPos0 | Transmitter Output Pulse Position 0 (Figure 15) | | -0.30 | 0 | 0.30 | ns |
| TPPos1 | Transmitter Output Pulse Position 1 | | 1.70 | 1/7 T _{clk} | 2.50 | ns |
| TPPos2 | Transmitter Output Pulse Position 2 | | 3.60 | 2/7 T _{clk} | 4.50 | ns |
| TPPos3 | Transmitter Output Pulse Position 3 | | 5.90 | 3/7 T _{clk} | 6.75 | ns |
| TPPos4 | Transmitter Output Pulse Position 4 | | 8.30 | 4/7 T _{clk} | 9.00 | ns |
| TPPos5 | Transmitter Output Pulse Position 5 | | 10.40 | 5/7 T _{clk} | 11.10 | ns |
| TPPos6 | Transmitter Output Pulse Position 6 | | 12.70 | 6/7 T _{clk} | 13.40 | ns |

Receiver Switching Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified.

| Symbol | Parameter | Min | Typ | Max | Units |
|--------|--|---|-----|------|-------|
| CLHT | CMOS/TTL Low-to-High Transition Time (Figure 6) | | 2.5 | 4.0 | ns |
| CHLT | CMOS/TTL High-to-Low Transition Time (Figure 6) | | 2.0 | 3.5 | ns |
| RCOP | RxCLK OUT Period | 15 | T | 50 | ns |
| RCOH | RxCLK OUT High Time | f = 65 MHz | 3.8 | 5 | ns |
| RCOL | RxCLK OUT Low Time | f = 65 MHz | 7.8 | 9 | ns |
| RSRC | RxOUT Setup to RxCLK OUT | f = 65 MHz | 2.5 | 4.2 | ns |
| RHRC | RxOUT Hold to RxCLK OUT | f = 65 MHz | 4.0 | 5.2 | ns |
| RCCD | RxCLK IN to RxCLK OUT Delay @ 25°C, V _{CC} = 5.0V (Figure 12) | 6.4 | | 10.7 | ns |
| RPLLS | Receiver Phase Lock Loop Set (Figure 14) | | | 10 | ms |
| RSKM | RxIN Skew Margin ⁽¹⁾ (Figure 16) | V _{CC} = 5V, T _A = 25°C | 600 | | ps |
| RPDD | Receiver Powerdown (Figure 19) | | | 1 | μs |

- (1) Receiver Skew Margin is defined as the valid data sampling region at the receiver inputs. This margin takes into account transmitter output skew (TCCS) and the setup and hold time (internal data sampling window), allowing for LVDS cable skew dependent on type/length and source clock (TxCLK IN) jitter $RSKM \geq \text{cable skew (type, length)} + \text{source clock jitter (cycle to cycle)}$

AC Timing Diagrams

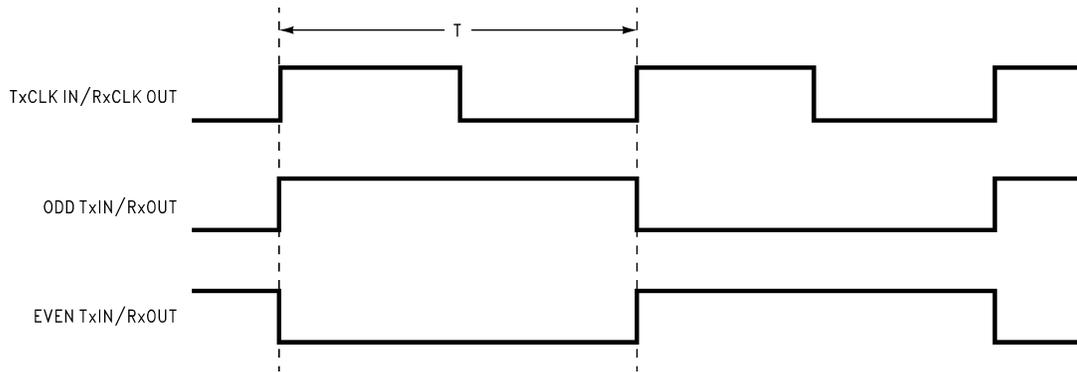


Figure 3. "Worst Case" Test Pattern

| Device Pin Name | Signal | Signal Pattern | Signal Frequency |
|--------------------|---------|----------------------|--------------------|
| TxCLK IN/RxCLK OUT | Dot Clk | [Square wave] | f |
| TxIN0/RxOUT0 | R0 | [Step function] | f/16 |
| TxIN1/RxOUT1 | R1 | [Step function] | f/8 |
| TxIN2/RxOUT2 | R2 | [Step function] | f/4 |
| TxIN3/RxOUT3 | R3 | [Square wave] | f/2 |
| TxIN4/RxOUT4 | R4 | [Steady State, Low] | Steady State, Low |
| TxIN5/RxOUT5 | R7 | [Steady State, Low] | Steady State, Low |
| TxIN6/RxOUT6 | R5 | [Steady State, Low] | Steady State, Low |
| TxIN7/RxOUT7 | G0 | [Steady State, Low] | Steady State, Low |
| TxIN8/RxOUT8 | G1 | [Step function] | f/16 |
| TxIN9/RxOUT9 | G2 | [Step function] | f/8 |
| TxIN10/RxOUT10 | G6 | [Step function] | f/4 |
| TxIN11/RxOUT11 | G7 | [Square wave] | f/2 |
| TxIN12/RxOUT12 | G3 | [Steady State, Low] | Steady State, Low |
| TxIN13/RxOUT13 | G4 | [Steady State, Low] | Steady State, Low |
| TxIN14/RxOUT14 | G5 | [Steady State, Low] | Steady State, Low |
| TxIN15/RxOUT15 | B0 | [Steady State, Low] | Steady State, Low |
| TxIN16/RxOUT16 | B6 | [Step function] | f/16 |
| TxIN17/RxOUT17 | B7 | [Step function] | f/8 |
| TxIN18/RxOUT18 | B1 | [Step function] | f/4 |
| TxIN19/RxOUT19 | B2 | [Square wave] | f/2 |
| TxIN20/RxOUT20 | B3 | [Steady State, Low] | Steady State, Low |
| TxIN21/RxOUT21 | B4 | [Steady State, Low] | Steady State, Low |
| TxIN22/RxOUT22 | B5 | [Steady State, Low] | Steady State, Low |
| TxIN23/RxOUT23 | RES | [Steady State, Low] | Steady State, Low |
| TxIN24/RxOUT24 | HSYNC | [Steady State, High] | Steady State, High |
| TxIN25/RxOUT25 | VSYNC | [Steady State, High] | Steady State, High |
| TxIN26/RxOUT26 | DEN | [Steady State, High] | Steady State, High |
| TxIN27/RxOUT27 | R6 | [Steady State, High] | Steady State, High |

- (1) The worst case test pattern produces a maximum toggling of digital circuits, LVDS I/O and CMOS/TTL I/O.
- (2) The 16 grayscale test pattern tests device power consumption for a "typical" LCD display pattern. The test pattern approximates signal switching needed to produce groups of 16 vertical stripes across the display.
- (3) Figure 3 and Figure 4 show a falling edge data strobe (TxCLK IN/RxCLK OUT).
- (4) Recommended pin to signal mapping. Customer may choose to define differently.

Figure 4. "16 Grayscale" Test Pattern

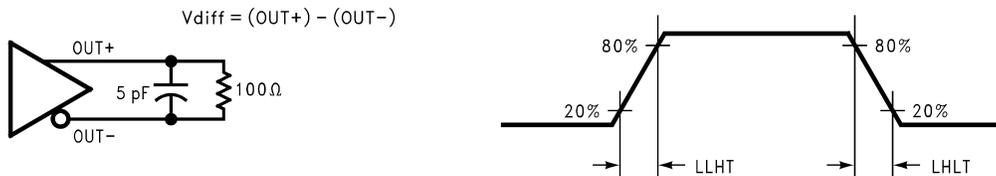


Figure 5. DS90CR583 (Transmitter) LVDS Output Load and Transition Times



Figure 6. DS90CR584 (Receiver) CMOS/TTL Output Load and Transition Times

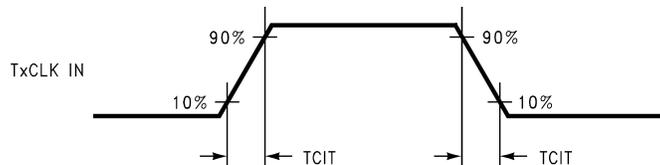
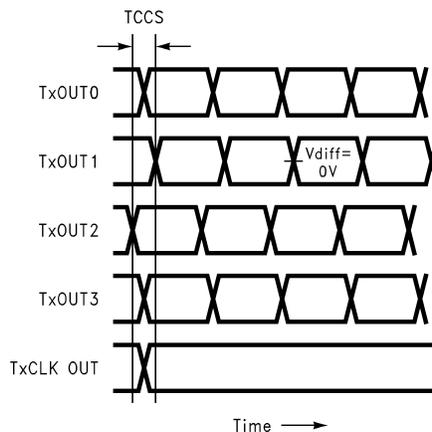


Figure 7. DS90CR583 (Transmitter) Input Clock Transition Time



Note: Measurements at $V_{diff} = 0V$

Note: TCCS measured between earliest and latest LVDS edges.

Note: TxCLK Differential High→Low Edge

Figure 8. DS90CR583 (Transmitter) Channel-to-Channel Skew and Pulse Width

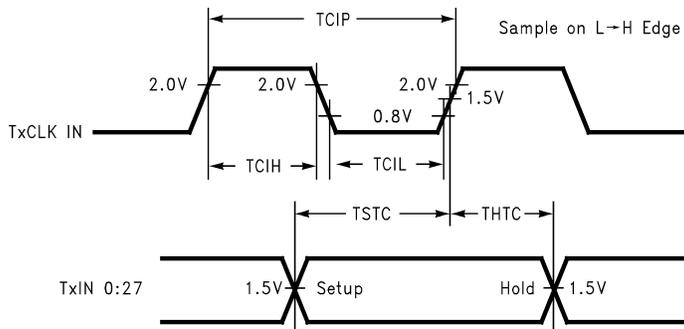


Figure 9. DS90CR583 (Transmitter) Setup/Hold and High/Low Times

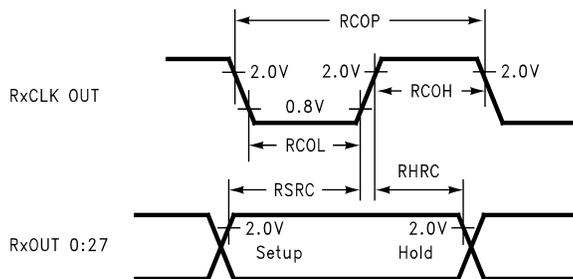


Figure 10. DS90CR584 (Receiver) Clock In to Clock Out Delay

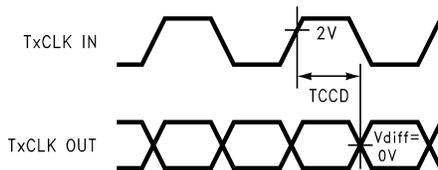


Figure 11. DS90CR583 (Transmitter) Clock In to Clock Out Delay

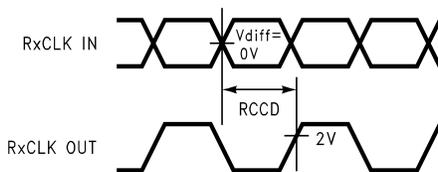


Figure 12. DS90CR584 (Receiver) Clock In to Clock Out Delay

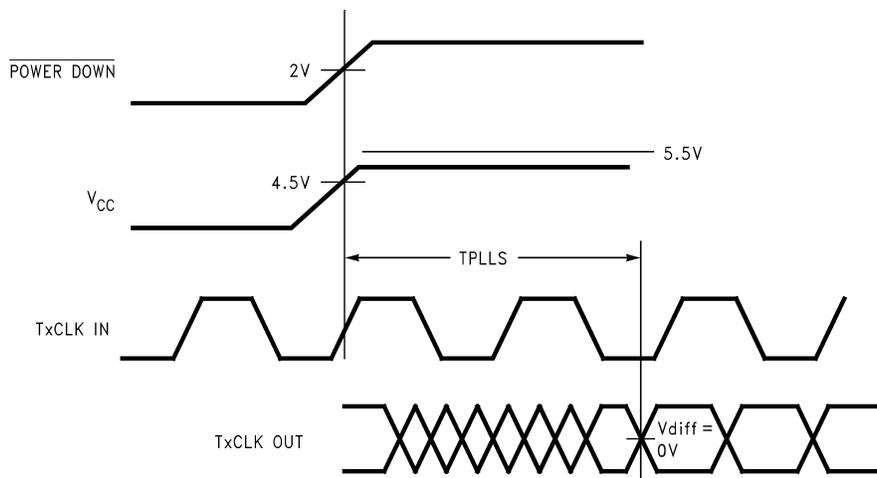


Figure 13. DS90CR583 (Transmitter) Phase Lock Loop Set Time

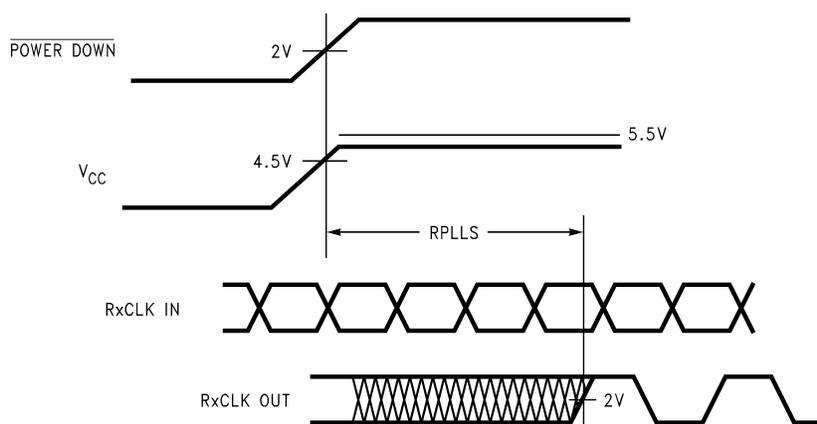


Figure 14. DS90CR584 (Receiver) Phase Lock Loop Set Time

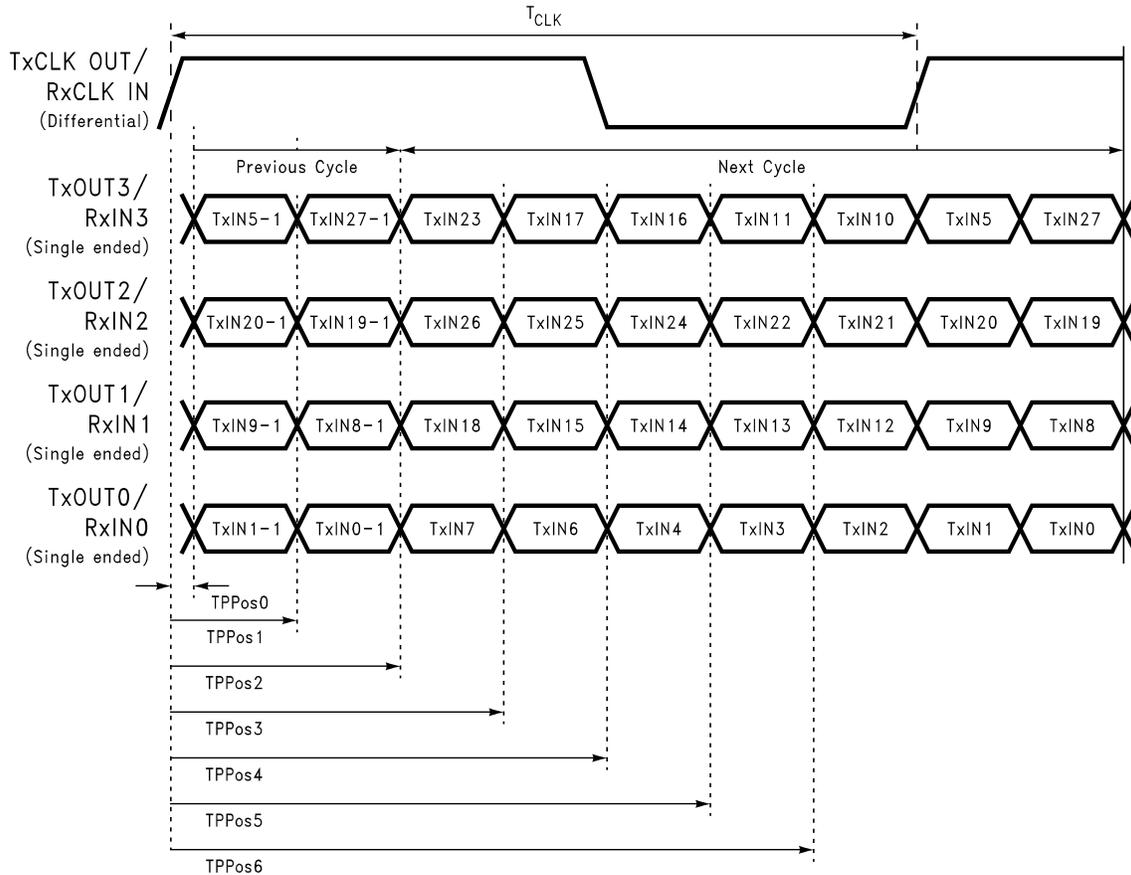
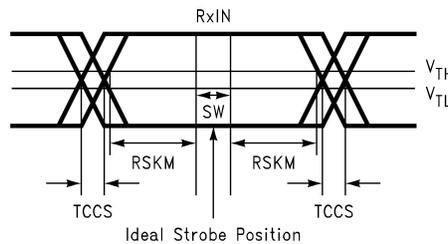


Figure 15. Transmitter LVDS Output Pulse Position Measurement



SW—Setup and Hold Time (Internal Data Sampling Window)
 TCCS—Transmitter Output Skew
 $RSKM \geq \text{Cable Skew (type, length)} + \text{Source Clock Jitter (cycle to cycle)}$
 Cable Skew—typically 10 ps–40 ps per foot

Figure 16. Receiver LVDS Input Skew Margin

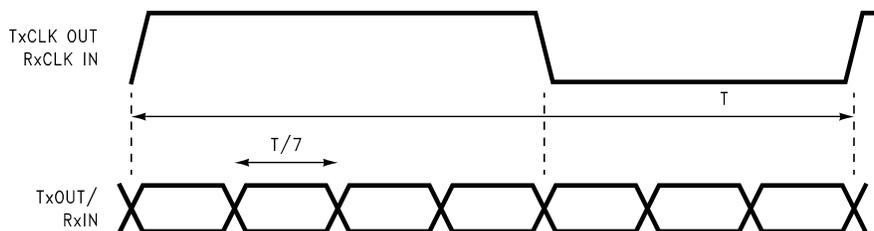


Figure 17. Seven Bits of LVDS in One Clock Cycle

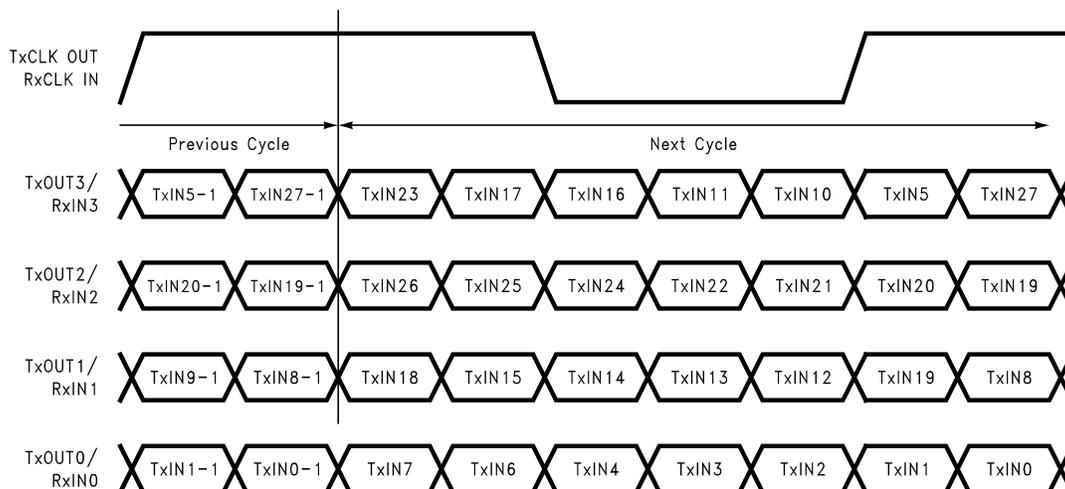


Figure 18. Parallel TTL Data Inputs Mapped to LVDS Outputs (DS90CR583)

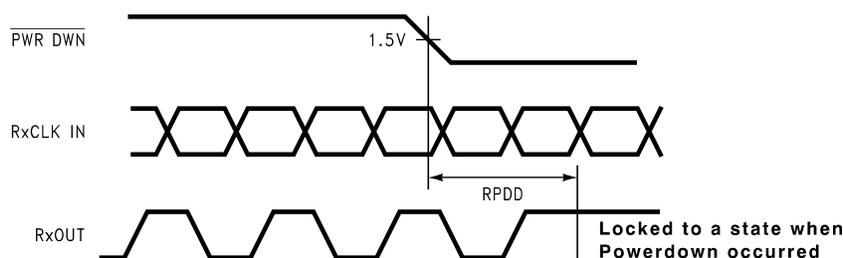


Figure 19. Receiver Powerdown Delay

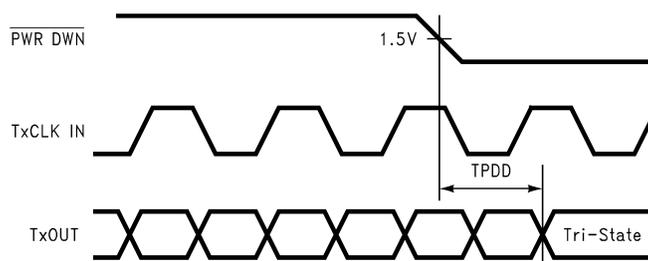


Figure 20. Transmitter Powerdown Delay

DS90CR583 Pin Descriptions—FPD Link Transmitter

| Pin Name | I/O | No. | Description |
|-----------------|-----|-----|--|
| TxIN | I | 28 | TTL level input. This includes: 8 Red, 8 Green, 8 Blue, and 4 control lines—FPLINE, FPFRAME, DRDY and CNTL (also referred to as HSYNC, VSYNC, Data Enable, CNTL) |
| TxOUT+ | O | 4 | Positive LVDS differential data output |
| TxOUT- | O | 4 | Negative LVDS differential data output |
| FPSHIFT IN | I | 1 | TTL level clock input. The falling edge acts as data strobe |
| TxCLK OUT+ | O | 1 | Positive LVDS differential clock output |
| TxCLK OUT- | O | 1 | Negative LVDS differential clock output |
| PWR DOWN | I | 1 | TTL level input. Assertion (low input) TRI-STATES the outputs, ensuring low current at power down |
| V _{CC} | I | 4 | Power supply pins for TTL inputs |
| GND | I | 5 | Ground pins for TTL inputs |

DS90CR583 Pin Descriptions—FPD Link Transmitter (continued)

| Pin Name | I/O | No. | Description |
|----------------------|-----|-----|-----------------------------------|
| PLL V _{CC} | I | 1 | Power supply pin for PLL |
| PLL GND | I | 2 | Ground pins for PLL |
| LVDS V _{CC} | I | 1 | Power supply pin for LVDS outputs |
| LVDS GND | I | 3 | Ground pins for LVDS outputs |

DS90CR584 Pin Descriptions—FPD Link Receiver

| Pin Name | I/O | No. | Description |
|----------------------|-----|-----|---|
| RxIN+ | I | 4 | Positive LVDS differential data inputs |
| RxIN- | I | 4 | Negative LVDS differential data inputs |
| RxOUT | O | 28 | TTL level data outputs. This includes: 8 Red, 8 Green, 8 Blue, and 4 control lines—FPLINE, FPFRAME, DRDY and CNTL (also referred to as HSYNC, VSYNC, Data Enable, CNTL) |
| RxCLK IN+ | I | 1 | Positive LVDS differential clock input |
| RxCLK IN- | I | 1 | Negative LVDS differential clock input |
| FPSHIFT OUT | O | 1 | TTL level clock output. The falling edge acts as data strobe |
| PWR DOWN | I | 1 | TTL level input. Assertion (low input) maintains the receiver outputs in the previous state |
| V _{CC} | I | 4 | Power supply pins for TTL outputs |
| GND | I | 5 | Ground pins for TTL outputs |
| PLL V _{CC} | I | 1 | Power supply for PLL |
| PLL GND | I | 2 | Ground pin for PLL |
| LVDS V _{CC} | I | 1 | Power supply pin for LVDS inputs |
| LVDS GND | I | 3 | Ground pins for LVDS inputs |

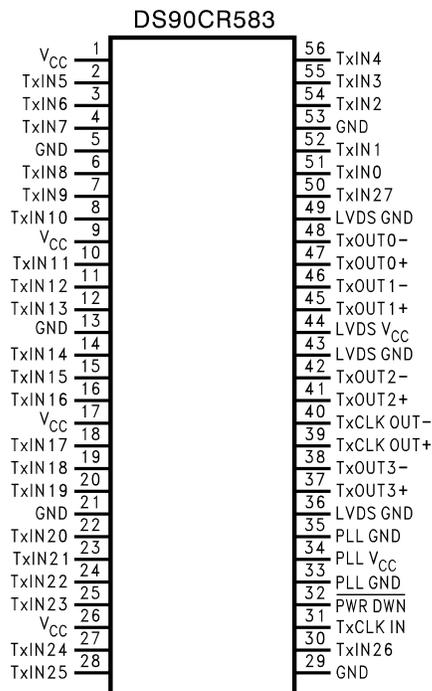
Connection Diagram


Figure 21. 56 Pin TSSOP
See Package Number DGG

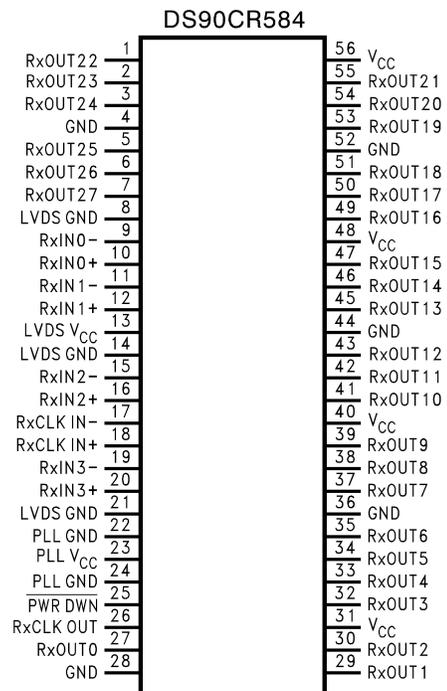


Figure 22. 56 Pin TSSOP
See Package Number DGG

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